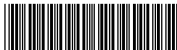


Search Notes

Application/Control No.

09/967,242

Examiner

JOHN J. LEE

Applicant(s)/Patent under
Reexamination

GECK ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	434,404.1 411,415 414,1,410 420	12/10/2008	J.L
455	414,2,433	12/10/2008	J.L
455	452,1,517	12/10/2008	J.L
455	515,516	12/10/2008	J.L
455	67,11,565	12/10/2008	J.L
455	435,1	12/10/2008	J.L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
455	434,404.1	12/16/2008	J.L
455	411,415	12/16/2008	J.L
455	414,1,515	12/16/2008	J.L
Interference and Inventor Search		12/16/2008	J.L

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	12/10/2008	J.L